

Data Sheet

January 2002

# 2.5A, 30V, 0.150 Ohm, Dual P-Channel LittleFET™ Power MOSFET

The RF1K49223 Dual P-Channel power MOSFET is manufactured using an advanced MegaFET process. This process, which uses feature sizes approaching those of LSI integrated circuits, gives optimum utilization of silicon, resulting in outstanding performance. It is designed for use in applications such as switching regulators, switching converters, motor drivers, relay drivers, and low voltage bus switches. This device can be operated directly from integrated circuits.

Formerly developmental type TA49223.

## **Ordering Information**

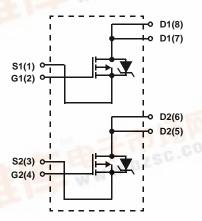
PART NUMBER	PACKAGE	BRAND		
RF1K49223	MS-012AA	RF1K49223		

NOTE: When ordering, use the entire part number. For ordering in tape and reel, add the suffix 96 to the part number, i.e. RF1K4922396.

#### **Features**

- 2.5A, 30V
- $r_{DS(ON)} = 0.150\Omega$
- Temperature Compensating PSPICE<sup>®</sup> Model
- Thermal Impedance PSPICE Model
- Peak Current vs Pulse Width Curve
- UIS Rating Curve
- Related Literature
  - TB334 "Guidelines for Soldering Surface Mount Components to PC Boards"

## Symbol



## **Packaging**

#### JEDEC MS-012AA





#### RF1K49223

# **Absolute Maximum Ratings** $T_A = 25$ °C Unless Otherwise Specified

	RF1K49223	UNITS
Drain to Source Voltage	-30	V
Drain to Gate Voltage ( $R_{GS} = 20k\Omega$ )	-30	V
Gate to Source Voltage	±20	V
Drain Current		
Continuous (Pulse Width = 5s)	2.5	Α
Pulsed I <sub>DM</sub>	Refer to Peak Current Curve	
Pulsed Avalanche RatingE <sub>AS</sub>	Refer to UIS Curve	
Power Dissipation	2	W
Derate Above 25°C	0.016	W/oC
Operating and Storage Temperature	-55 to 150	oC
Maximum Temperature for Soldering		
Leads at 0.063in (1.6mm) from Case for 10s	300	oC
Package Body for 10s, See Techbrief 334	260	°C

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

#### NOTE:

1.  $T_J = 25^{\circ}C$  to  $125^{\circ}C$ .

# **Electrical Specifications** $T_A = 25^{\circ}C$ , Unless Otherwise Specified

PARAMETER	SYMBOL	TEST CONDITIONS		MIN	TYP	MAX	UNITS
Drain to Source Breakdown Voltage	BV <sub>DSS</sub>	$I_D = 250\mu A, V_{GS} = 0V, (Figure 12)$		-30	-	-	V
Gate to Source Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D = 250\mu A, (Figure 11)$		-1	-	-3	V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = -30V$ , $T_{A} = 25^{\circ}C$	$T_A = 25^{\circ}C$	-	-	-1	μΑ
		$V_{GS} = 0V$	T <sub>A</sub> = 150°C	-	-	-50	μΑ
Gate to Source Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> = ±20V	V <sub>GS</sub> = ±20V		-	±100	nA
Drain to Source On Resistance	r <sub>DS(ON)</sub>	I <sub>D</sub> = 2.5A,	V <sub>GS</sub> = -10V	-	-	0.150	Ω
		(Figure 9, 10)	V <sub>GS</sub> = -4.5V	-	-	0.360	Ω
Turn-On Time	ton	$V_{DD} = -15V, I_{D} \cong 2.5A,$ $R_{L} = 6\Omega, V_{GS} = -10V,$ $R_{GS} = 25\Omega$		-	-	40	ns
Turn-On Delay Time	t <sub>d</sub> (ON)			-	9	-	ns
Rise Time	t <sub>r</sub>			-	19	-	ns
Turn-Off Delay Time	t <sub>d(OFF)</sub>			-	60	-	ns
Fall Time	t <sub>f</sub>			-	34	-	ns
Turn-Off Time	t <sub>OFF</sub>			-	-	140	ns
Total Gate Charge	Q <sub>g(TOT)</sub>	V <sub>GS</sub> = 0V to -20V	V <sub>DD</sub> = -24V,	-	28	35	nC
Gate Charge at -10V	Q <sub>g(-10)</sub>	$V_{GS} = 0V \text{ to } -10V$ $I_D \cong 2.5A,$ $R_1 = 9.6\Omega$	-	15	19	nC	
Threshold Gate Charge	Q <sub>g(TH)</sub>	$V_{GS} = 0V \text{ to } -2V$	$I_{g(REF)} = -1.0 \text{mA}$ (Figure 14)	-	1.5	1.9	nC
Input Capacitance	C <sub>ISS</sub>	V <sub>DS</sub> = -25V, V <sub>GS</sub> = 0V, f = 1MHz (Figure 13)		-	580	-	pF
Output Capacitance	C <sub>OSS</sub>			-	260	-	pF
Reverse Transfer Capacitance	C <sub>RSS</sub>			-	38	-	pF
Thermal Resistance Junction to Ambient	$R_{\theta JA}$	Pulse Width = 1s Device mounted on FR-4 material		-	-	62.5	°C/W

## **Source to Drain Diode Specifications**

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNITS
Source to Drain Diode Voltage	$V_{SD}$	I <sub>SD</sub> = -2.5A	-	-	-1.25	V
Reverse Recovery Time	t <sub>rr</sub>	$t_{rr}$ $I_{SD}$ =-2.5A, $dI_{SD}/dt = 100A/\mu s$		-	49	ns

©2002 Fairchild Semiconductor Corporation RF1K49223 Rev. B

## **Typical Performance Curves**

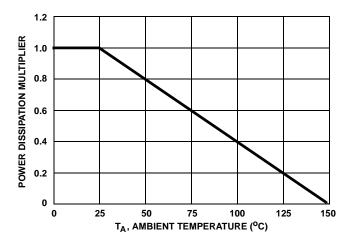


FIGURE 1. NORMALIZED POWER DISSIPATION vs AMBIENT TEMPERATURE

FIGURE 2. MAXIMUM CONTINUOUS DRAIN CURRENT vs AMBIENT TEMPERATURE

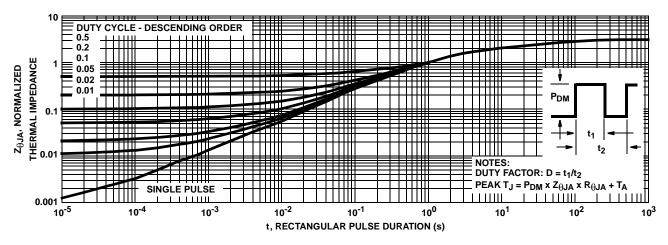


FIGURE 3. NORMALIZED MAXIMUM TRANSIENT THERMAL IMPEDANCE

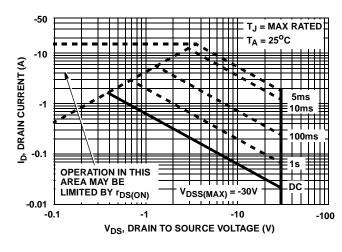


FIGURE 4. FORWARD BIAS SAFE OPERATING AREA

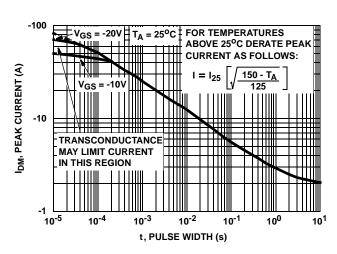
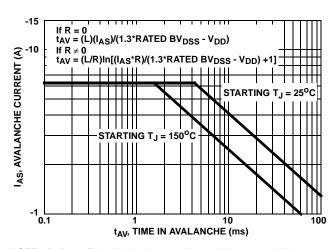


FIGURE 5. PEAK CURRENT CAPABILITY

## Typical Performance Curves (Continued)



NOTE: Refer to Fairchild Application Notes AN9321 and AN9322. FIGURE 6. UNCLAMPED INDUCTIVE SWITCHING CAPABILITY

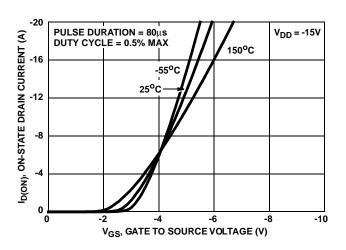


FIGURE 8. TRANSFER CHARACTERISTICS

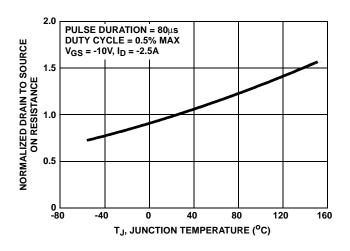


FIGURE 10. NORMALIZED DRAIN TO SOURCE ON RESISTANCE vs JUNCTION TEMPERATURE

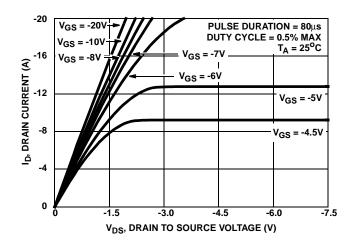


FIGURE 7. SATURATION CHARACTERISTICS

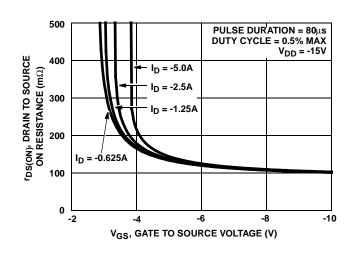


FIGURE 9. DRAIN TO SOURCE ON RESISTANCE vs GATE VOLTAGE AND DRAIN CURRENT

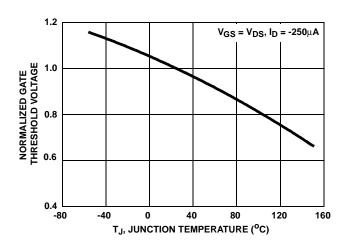
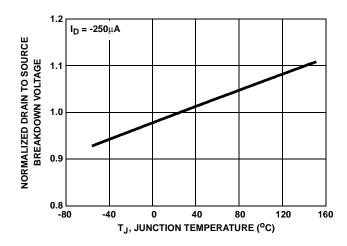


FIGURE 11. NORMALIZED GATE THRESHOLD VOLTAGE vs JUNCTION TEMPERATURE

©2002 Fairchild Semiconductor Corporation RF1K49223 Rev.

## Typical Performance Curves (Continued)



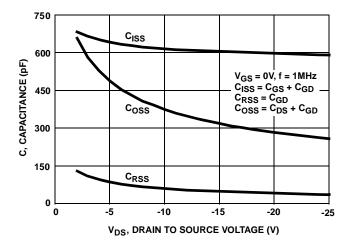
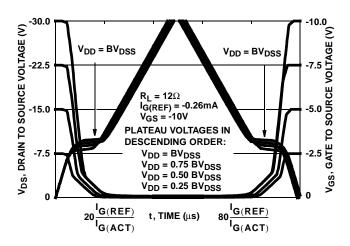


FIGURE 12. NORMALIZED DRAIN TO SOURCE BREAKDOWN VOLTAGE vs JUNCTION TEMPERATURE

FIGURE 13. CAPACITANCE vs DRAIN TO SOURCE VOLTAGE



NOTE: Refer to Fairchild Application Notes AN7254 and AN7260.

FIGURE 14. NORMALIZED SWITCHING WAVEFORMS FOR CONSTANT GATE CURRENT

#### Test Circuits and Waveforms

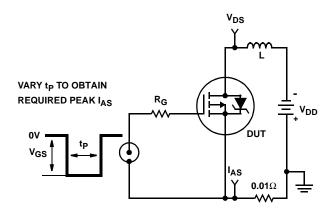


FIGURE 15. UNCLAMPED ENERGY TEST CIRCUIT

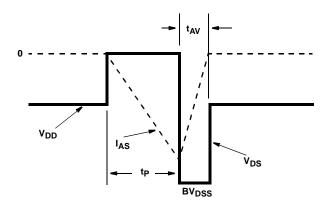


FIGURE 16. UNCLAMPED ENERGY WAVEFORMS

002 Fairchild Semiconductor Corporation RF1K49223 Re

## Test Circuits and Waveforms (Continued)

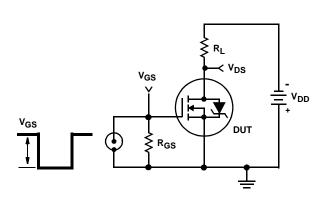


FIGURE 17. SWITCHING TIME TEST CIRCUIT

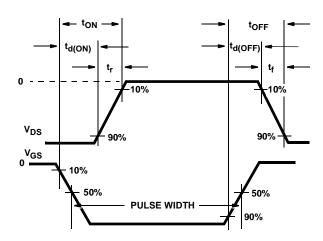


FIGURE 18. RESISTIVE SWITCHING WAVEFORMS

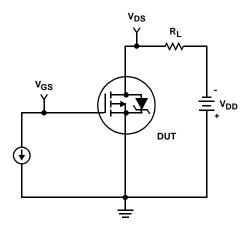


FIGURE 19. GATE CHARGE TEST CIRCUIT

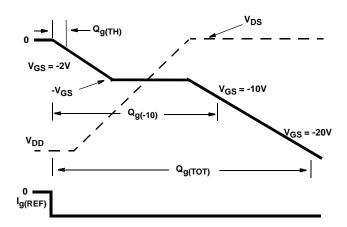


FIGURE 20. GATE CHARGE WAVEFORMS

## Soldering Precautions

The soldering process creates a considerable thermal stress on any semiconductor component. The melting temperature of solder is higher than the maximum rated temperature of the device. The amount of time the device is heated to a high temperature should be minimized to assure device reliability. Therefore, the following precautions should always be observed in order to minimize the thermal stress to which the devices are subjected.

- 1. Always preheat the device.
- The delta temperature between the preheat and soldering should always be less than 100°C. Failure to preheat the device can result in excessive thermal stress which can damage the device.
- The maximum temperature gradient should be less than 5°C per second when changing from preheating to soldering.

- The peak temperature in the soldering process should be at least 30°C higher than the melting point of the solder chosen.
- The maximum soldering temperature and time must not exceed 260°C for 10 seconds on the leads and case of the device.
- After soldering is complete, the device should be allowed to cool naturally for at least three minutes, as forced cooling will increase the temperature gradient and may result in latent failure due to mechanical stress.
- During cooling, mechanical stress or shock should be avoided.

002 Fairchild Semiconductor Corporation RF1K49223 Rev

#### **PSPICE Electrical Model**

SUBCKT RF1K49223 2 1 3 :rev 4/7/97

```
CA 12 8 7.29e-10
                                                                                                         LDRAIN
                                                               ESG
CB 15 14 5.01e-10
                                                                                                                  DRAIN
CIN 6 8 5.55e-10
                                                                <u>8</u>
                                                        10
                                                                                                        RLDRAIN
                                                                         ₹RSLC1
DBODY 5 7 DBODYMOD
DBREAK 7 11 DBREAKMOD
                                                             RSLC2
DPLCAP 10 6 DPLCAPMOD
                                                                                       EBREAK
                                                                             ESLC
                                                                                                18
EBREAK 5 11 17 18 -35.46
                                                                           50
                                                  DPLCAP
EDS 14 8 5 8 1
                                                                           RDRAIN
                                                                                                       DBODY
EGS 13 8 6 8 1
FSG 5 10 8 6 1
                                                                EVTHRES
EVTHRES 6 21 19 8 1
                                                                            21
                                                                   19
8
                                                                                       ▶ MWEAK
EVTEMP 6 20 18 22 1
                                    LGATE
                                                   EVTEMP
                           GATE
                                            RGATE
                                                      22
                                           9
                                                  20
IT 8 17 1
                                                                                         DBREAK
                                                                        ▶ MSTRO
                                   RLGATE
                                                                                                        LSOURCE
LDRAIN 2 5 1e-9
                                                                     CIN
                                                                                                                 SOURCE
LGATE 1 9 1.27e-9
                                                                               8
LSOURCE 3 7 4.20e-10
                                                                                        RSOURCE
                                                                                                       RLSOURCE
MMED 16 6 8 8 MMEDMOD
                                                    S1A
                                                               S2A
MSTRO 16 6 8 8 MSTROMOD
                                                                                            RBREAK
                                                       13
8
MWEAK 16 21 8 8 MWEAKMOD
                                                                    15
                                                                                         17
                                                             13
RBREAK 17 18 RBREAKMOD 1
                                                    S1B
                                                             o S2B
                                                                                                      RVTEMP
RDRAIN 50 16 RDRAINMOD 19.3e-3
                                                          13
                                                                    СВ
RGATE 9 20 7.44
                                                                                                      19
                                              CA
                                                                                       IT
                                                                          14
RLDRAIN 2 5 10
RLGATE 1 9 12.7
                                                                                                        VBAT
                                                       EGS
                                                                  EDS
RLSOURCE 3 7 4.2
RSLC1 5 51 RSLCMOD 1e-6
                                                                                      8
RSLC2 5 50 1e3
RSOURCE 8 7 RSOURCEMOD 65.37e-3
                                                                                            RVTHRES
RVTHRES 22 8 RVTHRESMOD 1
RVTEMP 18 19 RVTEMPMOD 1
S1A 6 12 13 8 S1AMOD
S1B 13 12 13 8 S1BMOD
S2A 6 15 14 13 S2AMOD
S2B 13 15 14 13 S2BMOD
VBAT 22 19 DC 1
ESLC 51 50 VALUE={(V(5,51)/ABS(V(5,51)))*(PWR(V(5,51)/(1e-6*48),2.5))}
.MODEL DBODYMOD D (IS = 3.30e-13 RS = 4.56e-2 TRS1 =6.98e-4 TRS2 =8.08e-7 CJO = 8.21e-10 TT = 3.51e-8 M=0.4)
MODEL DBREAKMOD D (RS = 8.18e- 1TRS1 =5.28e- 3TRS2 = -7.18e-5
.MODEL DPLCAPMOD D (CJO = 2.52e-1 0IS = 1e-3 0N = 10 M=0.6)
MODEL MMEDMOD PMOS (VTO= -1.95 KP=0.75 IS=1e-30 N=10 TOX=1 L=1u W=1u RG=7.44)
.MODEL MSTROMOD PMOS (VTO= -2.44 KP= 7.25 IS=1e-30 N=10 TOX=1 L=1u W=1u)
MODEL MWEAKMOD PMOS (VTO= -1.68 KP=0.045 IS=1e-30 N=10 TOX=1 L=1u W=1u RG=74.4 RS=0.1)
.MODEL RBREAKMOD RES (TC1 = 9.45e- 4TC2 = -1.01e-7)
.MODEL RDRAINMOD RES (TC1 = 3.69e-3 TC2 = 5.90e-6)
.MODEL RSLCMOD RES (TC1=3.46e-3 TC2= 1.26e-6)
.MODEL RSOURCEMOD RES (TC1=3.69e-3 TC2=5.90e-6)
.MODEL RVTHRESMOD RES (TC=-5.19e-4 TC2= 5.02e-6)
.MODEL RVTEMPMOD RES (TC1 = -3.54e- 3TC2 = -6.53e-7)
.MODEL S1AMOD VSWITCH (RON = 1e-5 ROFF = 0.1 VON = 6.94 VOFF= 3.94)
.MODEL S1BMOD VSWITCH (RON = 1e-5 ROFF = 0.1 VON = 3.94 VOFF= 6.94)
.MODEL S2AMOD VSWITCH (RON = 1e-5 ROFF = 0.1 VON = 0.40 VOFF= -2.60)
.MODEL S2AMOD VSWITCH (RON = 1e-5 ROFF = 0.1 VON = -2.60 VOFF= 0.40)
.ENDS
```

NOTE:For further discussion of the PSPICE model, consult **A New PSPICE Sub-Circuit for the Power MOSFET Featuring Global Temperature Options**;IEEE Power Electronics Specialist Conference Records, 1991, written by William J. Hepp and C. Frank Wheatley.

©2002 Fairchild Semiconductor Corporation RF1K49223 Rev. B

## RF1K49223

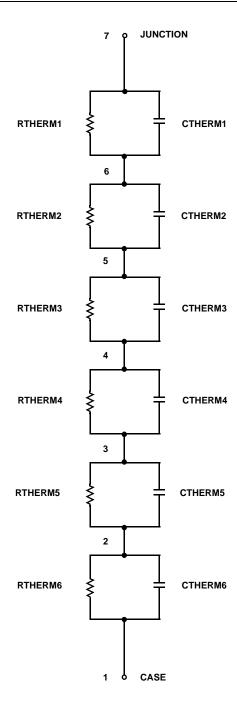
#### **PSPICE Thermal Model**

REV 28 Feb 97

RF1K49223

CTHERM1 7 6 1.00e-7
CTHERM2 6 5 9.00e-4
CTHERM3 5 4 3.00e-3
CTHERM4 4 3 4.00e-2
CTHERM5 3 2 5.20e-3
CTHERM6 2 1 1.90e-2

RTHERM1 7 6 7.10e-2
RTHERM2 6 5 1.90e-1
RTHERM3 5 4 5.95e-1
RTHERM4 4 3 4.27
RTHERM5 3 2 1.2e1
RTHERM6 2 1 1.04e2



#### **TRADEMARKS**

The following are registered and unregistered trademarks Fairchild Semiconductor owns or is authorized to use and is not intended to be an exhaustive list of all such trademarks.

 $VCX^{TM}$ SMART START™ ACEx™ FAST ® OPTOLOGIC™ FASTr™ STAR\*POWER™ Bottomless™ OPTOPLANAR™ Stealth™ CoolFET™  $\mathsf{PACMAN^{\mathsf{TM}}}$ FRFET™ SuperSOT™-3  $CROSSVOLT^{TM}$ GlobalOptoisolator™ **POPTM** SuperSOT™-6 GTO™ DenseTrench™ Power247™  $HiSeC^{\scriptscriptstyle\mathsf{TM}}$ SuperSOT™-8  $\mathsf{DOME}^\mathsf{TM}$ PowerTrench® SyncFET™ EcoSPARK™ ISOPLANAR™ QFET™ TinyLogic™ LittleFET™ E<sup>2</sup>CMOS<sup>TM</sup> QSTM TruTranslation™ EnSigna™ MicroFET™ QT Optoelectronics™ UHC™ FACT™ MicroPak™ Quiet Series™ UltraFET® FACT Quiet Series™ MICROWIRE™ SILENT SWITCHER®

STAR\*POWER is used under license

#### **DISCLAIMER**

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS. NOR THE RIGHTS OF OTHERS.

#### LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION. As used herein:

- 1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, or (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in significant injury to the
- A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

#### **PRODUCT STATUS DEFINITIONS**

#### **Definition of Terms**

Datasheet Identification	Product Status	Definition
Advance Information	Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	This datasheet contains preliminary data, and supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
No Identification Needed	Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
Obsolete	Not In Production	This datasheet contains specifications on a product that has been discontinued by Fairchild semiconductor. The datasheet is printed for reference information only.